

LDB/LSB Series

InGaAs Linear Photodiode Arrays

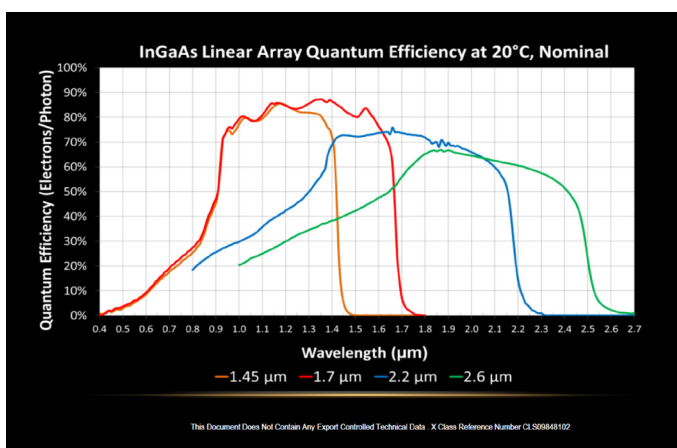
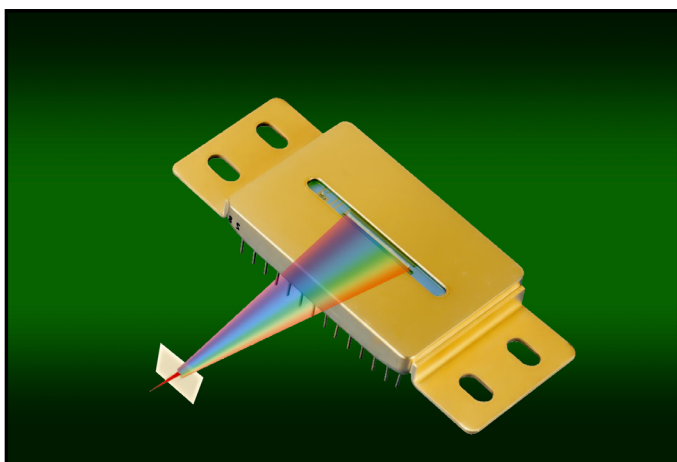
The LDB/LSB Series linear InGaAs photodiode arrays have set the standard for high performance in near-infrared spectroscopy and imaging applications. These arrays are widely used for optical performance monitoring of S, C & L band channels in DWDM networks. Other applications include agricultural sorting, biomedical analysis, thermal imaging and industrial process control.

SUI produces LDB/LSB InGaAs array products with 256 and 512 elements on a 25 μm or 50 μm pixel pitch with pixel heights of 250 and 500 μm . Standard wavelength range of 0.8 to 1.7 μm , a shorter range of 0.8 to 1.45 μm or extended wavelength range of 1.1 to 2.2 μm . The photodetector arrays are hybridized with CMOS readout integrated circuits (ROIC) of SUI exclusive design to offer maximum noise immunity and sensitivity.

Operating circuit designs need only provide for one analog supply and two digital control lines for optimum ROIC performance. Two separate gains are selectable with a single input. Arrays are available with thermoelectric coolers for temperature stabilization and monitoring. SUI LDB/LSB Series photodiode arrays are telecommunication system reliable and available in volume.

FEATURES

- Easy to use analog design
- 25 μm or 50 μm pitch – one-half inch and one-quarter inch array
- Wavelength ranges 0.8 μm to 2.2 μm
- Pixel heights of 250 μm or 500 μm
- Antiblooming to prevent charge overflow from saturated pixels
- Two separate gains are selectable with a single input
- Available with 1 or 2 stage thermoelectric cooler, or without a cooler for uncooled or externally-cooled operations
- Max I/O 5KHz – Analog output
- ESD Resistant



| ELECTRICAL INPUTS | | | | |
|--|------|------|--|------|
| Parameter/Description | Unit | Min. | Typical | Max. |
| V _{DD} /Analog supply voltage | V | 4.90 | 5.00 | 5.25 |
| V _{SS} /Analog supply ground | V | | 0 | |
| V _{DP} /Amplifier dead potential | V | | 3.25 | |
| V _{CLK} /Digital pixel clock | V | | Hi: V _{DD} Low: V _{SS} | |
| V _{LSYNC} /Digital exposure control | V | | Hi: V _{DD} Low: V _{SS} | |
| V _{CAP} /Digital gain control | V | | Hi: V _{DD} Low: V _{SS} | |

| PERFORMANCE CHARACTERISTICS | | | | |
|--|--------------------------------|------|--|------|
| Parameter | Unit | Min. | Typical | Max. |
| Peak wavelength sensitivity (λ_{pk}) | µm | | 1.5 | |
| Responsivity (at λ_{pk}) | nV/photon | 10.5 | | |
| Photoresponse nonuniformity (PRNU) | % | | 5 | 10 |
| Gain | nV/electron | | 400 ¹ , 15.4 ² | |
| Saturation charge | pC | | 0.8 ¹ , 20.8 ² | |
| Readout noise | electron/ $\sqrt{\text{scan}}$ | | 800 ¹ , 10,000 ² | |
| Pixel clock | MHz | | | 1.25 |
| Readout rate per output | Mpix/sec/output | | | 2.5 |
| Inoperable pixels | | | | 0 |

¹ High-sensitivity mode: high gain capacitor
² High dynamic range mode: low gain capacitor

| ABSOLUTE MAXIMUM RATINGS | | | | |
|--|------|------|---------|------|
| Parameter/Description | Unit | Min. | Typical | Max. |
| Power consumption (V _{DD} =5.00V) | LDB | | | 300 |
| | LSB | | | 150 |
| Operating temperature range | °C | -20 | | +70 |
| Storage temperature range | °C | -40 | | +85 |

| LINEAR ARRAY COMPARISON TABLE (Representative Values) | | | | |
|---|--------------|------------------------------|-------------------------------|---------------------|
| Material type | Dark Current | 50% QE Cut-on λ (µm) | 50% QE Cut-off λ (µm) | Peak λ (µm) |
| 1.45 µm | 1.3 Pa | 0.91 | 1.415 | 1.17 |
| 1.7 µm | 2.3 pA | 0.91 | 1.65 | 1.36 |
| 2.2 µm | 10 nA | 1.3 | 2.155 | 1.67 |
| 2.6 µm | 100 nA | 1.64 | 2.41 | 1.84 |



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